

1700V 900mΩ Silicon Carbide Power MOSFET N-Channel Enhancement Mode

#### **Features**

- Fully isolated package for simplified assembly
- High-speed switching with low capacitances
- High blocking voltage with low R<sub>DS(on)</sub>
- 12V..18V / 0V  $V_{GS}$  compatible with most flyback controllers
- Ultra-low drain-gate capacitance
- Halogen free, RoHS compliant

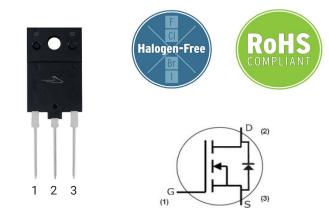
#### **Benefits**

- Smooth switching waveforms
- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Increase system switching frequency
- Increase system reliability

### **Typical Applications**

- Auxillary power supplies
- Switch mode power supplies
- High-voltage capacitive loads

#### **Package**



Orderable Part Number	Package	Marking	
C3M0900170M	TO-3PF 3L	C3M0900170M	

# **Key Parameters**

Parameter	Symbol	Min.	Тур.	Max	Unit	Conditions	Note
Drain - Source Voltage	V <sub>DS</sub>			1700		T <sub>c</sub> = 25°C	
Maximum Gate - Source Voltage	V <sub>GS(max)</sub>	-8		+20		Transient	
Operational Turn-On Gate - Source Voltage	V <sub>GS op</sub>		+12+18		V		
Operational Turn-Off Gate - Source Voltage	V <sub>GS op</sub>		-40				
				4.0		$V_{GS} = 15V, T_{C} = 25 ^{\circ}C, T_{J} \le 175 ^{\circ}C$	
DC Continuous Drain Current	l <sub>D</sub>			2.9	А	$V_{GS} = 15V, T_{C} = 100 ^{\circ}\text{C}, T_{J} \leq 175 ^{\circ}\text{C}$	Note 2
Pulsed Drain Current	I <sub>DM</sub>			15		$t_{Pmax}$ limited by $T_{jmax}$ $V_{GS} = 15V$ , $T_{C} = 25$ °C	Fig. 22
Power Dissipation	P <sub>D</sub>			33	W	T <sub>c</sub> = 25 ° C, T <sub>J</sub> = 175 °C	Fig. 20
Operating Junction and Storage Temperature	$T_{J},T_{stg}$			-55 to +175	°C		
Mounting Torque	M <sub>D</sub>			1 8.8	Nm lbf-in	M3 or 6-32 screw	

Note (1): Review Application Note PRD-04814 for additional details

Note (2): Verified by design

**Electrical Characteristics** (T<sub>c</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	1700			V	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 100 μA	
.,	Gate Threshold Voltage	1.8	3.1	4.2	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 0.55 mA	Fig. 11
$V_{GS(th)}$			2.6		V	$V_{DS} = V_{GS}$ , $I_D = 0.55$ mA, $T_J = 175$ °C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		1	50	μΑ	V <sub>DS</sub> = 1700 V, V <sub>GS</sub> = 0 V	
I <sub>GSS</sub>	Gate-Source Leakage Current		10	250	nA	V <sub>GS</sub> = 15 V, V <sub>DS</sub> = 0 V	
D	Drain Course On Ctota Desistance		900	1250		V <sub>GS</sub> = 15 V, I <sub>D</sub> = 1.99 A	Fig. 4, 5, 6
R <sub>DS(on)</sub>	Drain-Source On-State Resistance		1938		mΩ	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 1.99 A, T <sub>J</sub> = 175°C	
	Transcenductores		1			V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 1.99 A	Fig. 7
<b>G</b> fs	Transconductance		1		S	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 1.99 A, T <sub>J</sub> = 175°C	
$C_{iss}$	Input Capacitance		202			V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1200 V	Fig. 17, 18
$C_{\text{oss}}$	Output Capacitance		8		pF	f = 100 kHz	
$C_{rss}$	Reverse Transfer Capacitance		1.4			Vac = 25 mV	
Eoss	Coss Stored Energy		8		μJ		Fig. 16
$C_{\text{o(er)}}$	Effective Output Capacitance (Energy Related)		10		_		
$C_{\text{o(tr)}}$	Effective Output Capacitance (Time Related)		13		pF	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0 to 1200V	Note: 3
E <sub>on</sub>	Turn-On Switching Energy (External Diode)		154			$V_{DS}$ =1200V, $V_{GS}$ =-4V/15V, $I_{D}$ =1.99A, $R_{G(ext)}$ =2.5 $\Omega$ , L=1707 $\mu$ H, $T_{J}$ =175°C	Fig 26, 28
E <sub>OFF</sub>	Turn-Off Switching Energy (External Diode)		15		μJ	FWD= External SiC DIODE	
t <sub>d(on)</sub>	Turn-On Delay Time		23				Fig 27, 28
t <sub>r</sub>	Rise Time		18		[	$\begin{array}{c} V_{DS} = 1200V, V_{GS} = -4V/15V \\ I_{D} = 1.99A, R_{G(ext)} = 2.5~\Omega~T_{J} = 175^{\circ}C \\ L = 1707\mu H \end{array}$	
t <sub>d(off)</sub>	Turn-Off Delay Time		19		ns	L=1707µH Timing relative to V <sub>DS</sub> Inductive load	
t <sub>f</sub>	Fall Time		43			Triming relative to v <sub>DS</sub> mudective load	
R <sub>G(int)</sub>	Internal Gate Resistance		31		Ω	f=1MHz, V <sub>AC</sub> =25mV	
$Q_{gs}$	Gate to Source Charge		4			V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = -4 V/15 V	Fig. 12
$Q_{gd}$	Gate to Drain Charge		4		nC	I <sub>D</sub> = 1.99 A	
Qg	Total Gate Charge		10	]		Per IEC60747-8-4 pg 21	

Note (3):  $C_{O(er)}$ , a lumped capacitance that gives same stored energy as Coss while Vds is rising from 0 to 1200V  $C_{O(tr)}$ , a lumped capacitance that gives same charging time as Coss while Vds is rising from 0 to 1200V

# **Reverse Diode Characteristics** ( $T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
	Diode Forward Voltage	4.7		٧	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 1 A	Fig. 8,
$V_{SD}$		4.2		٧	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 1 A, T <sub>J</sub> = 175 °C	9, 10
Is	Continuous Diode Forward Current	5		А	V <sub>GS</sub> = -4 V	
I <sub>SM</sub>	Diode pulse Current		15	А	$V_{GS}$ = -4 V, pulse width $t_P$ limited by $T_{jmax}$	
t <sub>rr</sub>	Reverse Recovery Time	40		ns		
Q <sub>rr</sub>	Reverse Recovery Charge	72		nC	V <sub>GS</sub> =-4V, Is=1.99A, V <sub>SD</sub> =1200V dif/dt=546A/ <sub>µs</sub> , T <sub>J</sub> =25°C	
I <sub>rrm</sub>	Reverse Recovery Current	3		А		
t <sub>rr</sub>	Reverse Recovery Time	40		ns	V <sub>ss</sub> =-4V, Is=1.99A, V <sub>ss</sub> =1200V dif/dt=246A/μs , Τ <sub>s</sub> =25 °C	
Q <sub>rr</sub>	Reverse Recovery Charge	57		nC		
I <sub>rrm</sub>	Reverse Recovery Current	2		А		

# **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
R <sub>0</sub> Jc	Thermal Resistance from Junction to Case	3.4	4.5	°C/W		

# **Typical Performance**

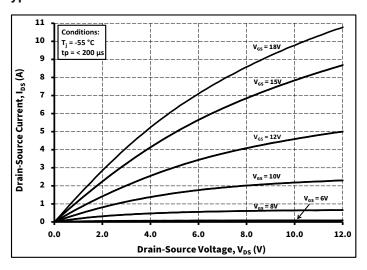


Figure 1. Output Characteristics  $T_J$  = -55 °C

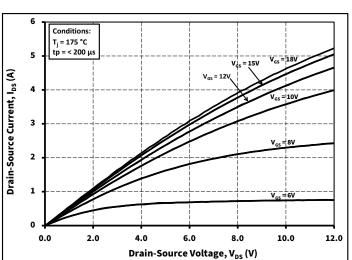


Figure 3. Output Characteristics T<sub>J</sub> = 175 °C

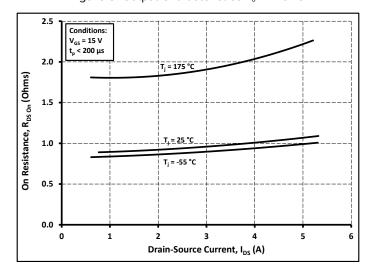
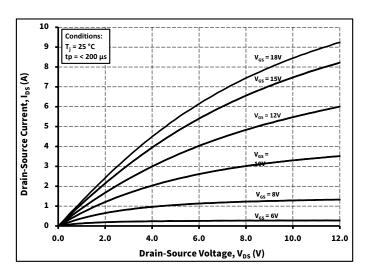


Figure 5. On-Resistance vs. Drain Current For Various Temperatures



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Figure 2. Output Characteristics  $T_J = 25$  °C

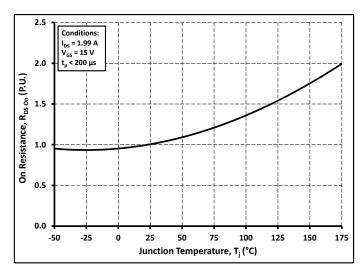


Figure 4. Normalized On-Resistance vs. Temperature

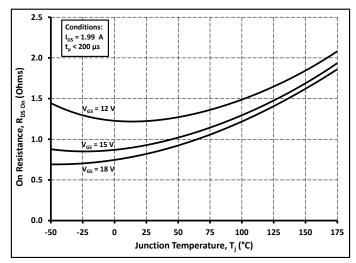


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

# **Typical Performance**

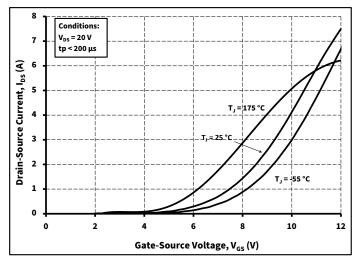


Figure 7. Transfer Characteristic for Various Junction Temperatures

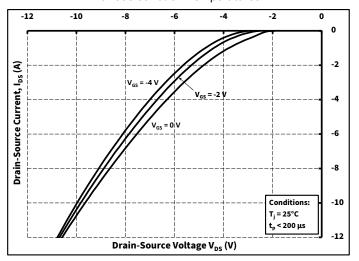


Figure 9. Body Diode Characteristic at 25 °C

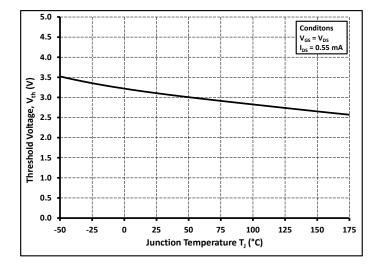


Figure 11. Threshold Voltage vs. Temperature

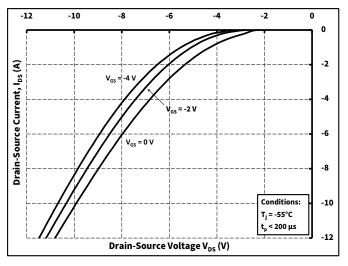


Figure 8. Body Diode Characteristic at -55 °C

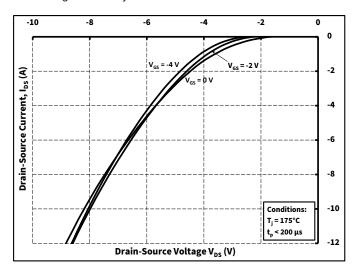


Figure 10. Body Diode Characteristic at 175 °C

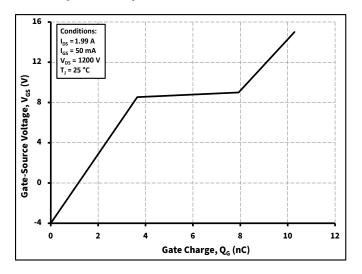


Figure 12. Gate Charge Characteristics

#### **Typical Performance**

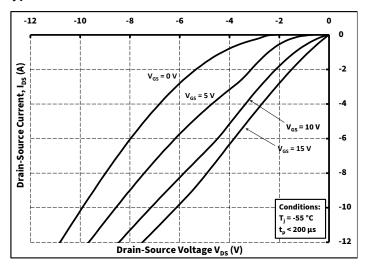


Figure 13. 3rd Quadrant Characteristic at -55 °C

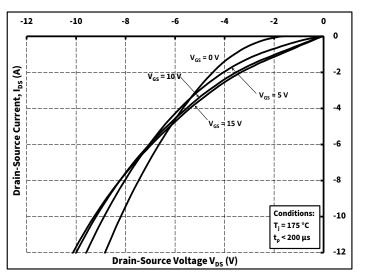


Figure 15. 3rd Quadrant Characteristic at 175 °C

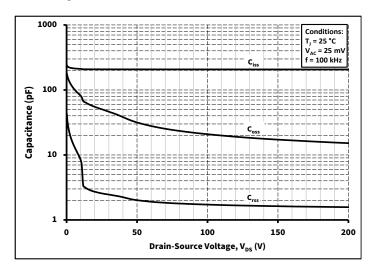


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

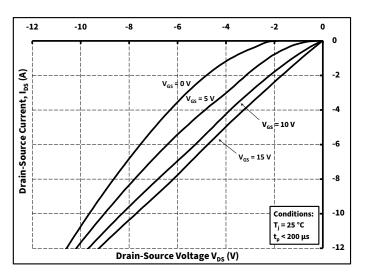


Figure 14. 3rd Quadrant Characteristic at 25 °C

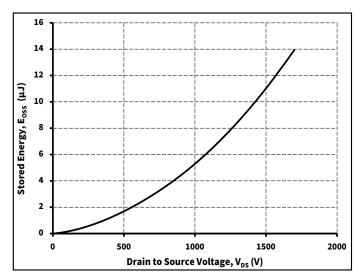


Figure 16. Output Capacitor Stored Energy

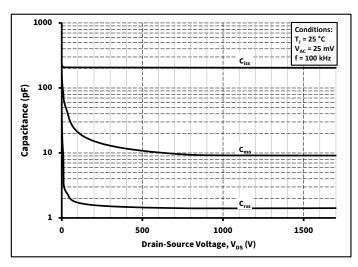


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1700V)

# **Typical Performance**

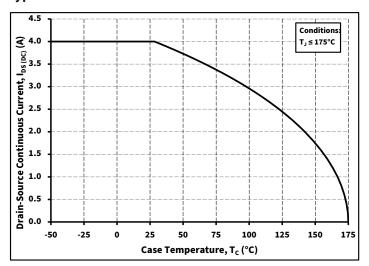


Figure 19. Continuous Drain Current Derating vs. Case Temperature

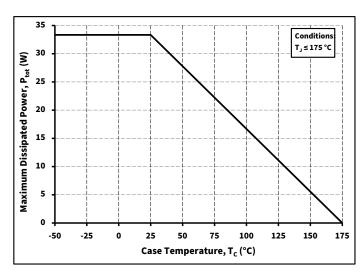


Figure 20. Max Power Dissipation vs. Case Temperature

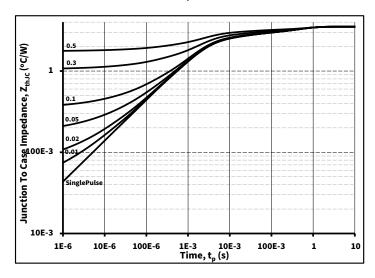


Figure 21. Transient Thermal Impedance (Junction-Case)

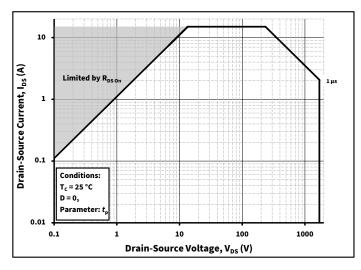


Figure 22. Safe Operating Area

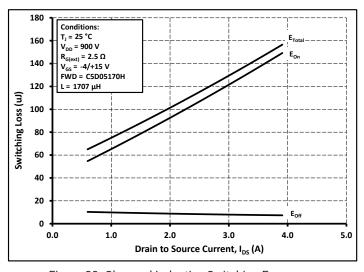


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD}$ =900V)

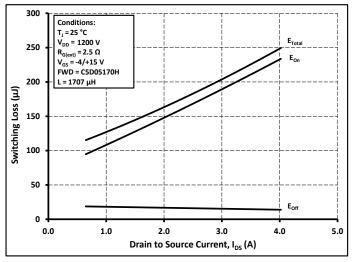


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD}$ =1200V)

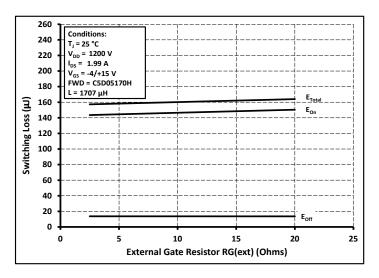


Figure 25. Clamped Inductive Switching Energy vs.  $R_{\rm G(ext)}$ 

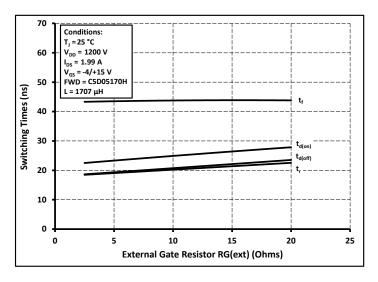


Figure 27. Switching Times vs.  $R_{\text{G(ext)}}$ 

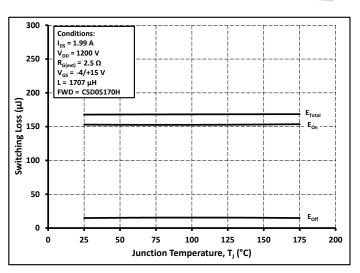


Figure 26. Clamped Inductive Switching Energy vs.
Temperature

### **Test Circuit Schematic**

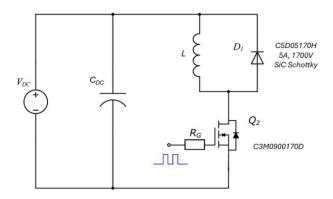
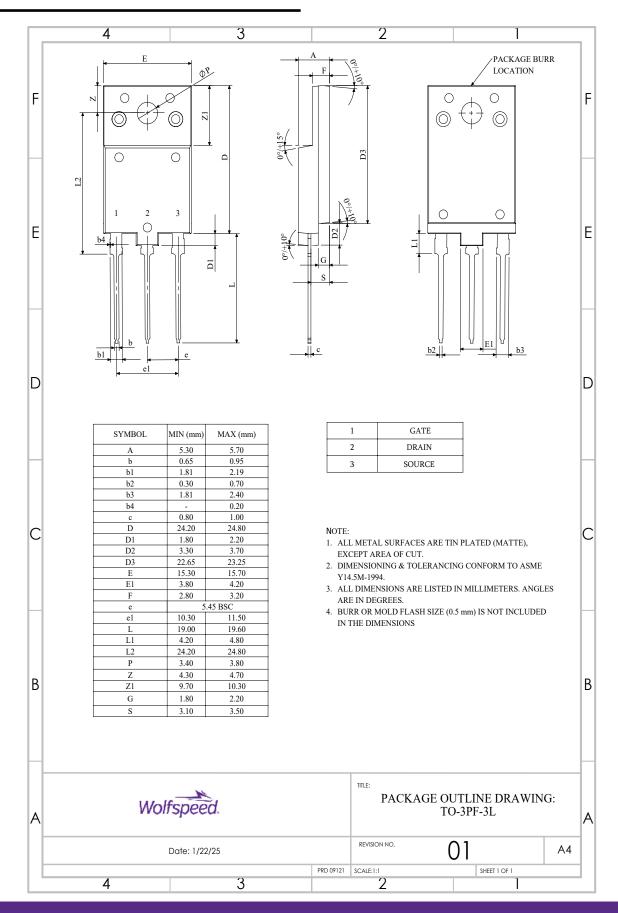


Figure 28. Clamped Inductive Switching Waveform Test Circuit

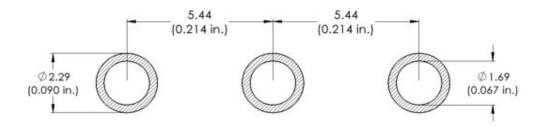
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## **Package Dimensions**



# **Recommended Solder Pad Lavout**

All dimensions in mm



# **Revision history**

Document Version	Date of release	Descriptiion of changes
1	February 2025	Initial release

# Notes & Disclaimer

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#### **Contact info:**

4600 Silicon Drive Durham, NC 27703 USA Tel: +1.919.313.5300 www.wolfspeed.com/power

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